

Application/Control No.	Applicant(s)/Patent under Reexamination
10/565,706	CHAN ET AL.
Examiner	Art Unit
lois A. Chali	1611

	SEARCHED					
Class	Subclass	Date	Examiner			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
IDS review Inventor name search WEST:All DB: USPT, PGPB, USOC, EPAB, JPAB, DWPI	2/2/2011	IG		